MOSFET – Power, Single N-Channel 60 V, 9.2 mΩ, 50 A

NVMYS9D3N06CL

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- LFPAK4 Package, Industry Standard
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_{.I} = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	60	V
Gate-to-Source Voltage	Э		V_{GS}	20	V
Continuous Drain		T _C = 25°C	I _D	50	Α
Current R _{θJC} (Notes 1, 3)	Steady	T _C = 100°C		35	
Power Dissipation	State	T _C = 25°C	P_{D}	46	W
R _{θJC} (Note 1)		T _C = 100°C		23	
Continuous Drain		T _A = 25°C	I _D	14	Α
Current R _{θJA} (Notes 1, 2, 3)	Steady	T _A = 100°C		10	
Power Dissipation	State	T _A = 25°C	P_{D}	3.6	W
R _{θJA} (Notes 1 & 2)		T _A = 100°C		1.8	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I _{DM}	290	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to + 175	°C
Source Current (Body Diode)			I _S	52	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 2.3 A)			E _{AS}	88	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	3.1	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	39	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

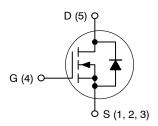


ON Semiconductor®

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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX	
60 V	9.2 mΩ @ 10 V	50 A	
	13 mΩ @ 4.5 V	30 A	

N-Channel





LFPAK4 CASE 760AB



9D3N06CL = Specific Device Code A = Assembly Location

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
OFF CHARACTERISTICS	•			-	-	-	-	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60			V	
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				28		mV/°C	
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			10		
		V _{DS} = 60 V	T _J = 125°C			250 μΑ		
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _G	iS = 20 V			100	nA	
ON CHARACTERISTICS (Note 4)								
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 35 \mu A$		1.2		2.0	V	
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-5.1		mV/°C	
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 25 A		8.0	9.2	0	
		V _{GS} = 4.5 V	I _D = 25 A		11	13	3 mΩ	
Forward Transconductance	9 _{FS}	V _{DS} =15 V, I	_D = 25 A		37		S	
CHARGES AND CAPACITANCES								
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 25 V			880			
Output Capacitance	C _{OSS}				450		pF	
Reverse Transfer Capacitance	C _{RSS}				11			
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} = 48 V; I _D = 25 A			4.5		nC	
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 48 V; I _D = 25 A			9.5		nC	
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 10 V, V _{DS} = 48 V; I _D = 25 A			1.0			
Gate-to-Source Charge	Q _{GS}				2.0		nC	
Gate-to-Drain Charge	Q_{GD}				0.8			
Plateau Voltage	V_{GP}				2.9		V	
SWITCHING CHARACTERISTICS (Note	e 5)							
Turn-On Delay Time	t _{d(ON)}				6.0			
Rise Time	t _r	V _{GS} = 10 V, V _I	ns = 48 V,		25		1	
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 25 \text{ A}, R_G = 2.5 \Omega$			16		ns	
Fall Time	t _f				2.0		1	
DRAIN-SOURCE DIODE CHARACTER	ISTICS					•		
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V, I _S = 25 A	T _J = 25°C		0.9	1.2	.,	
			T _J = 125°C		0.8		V	
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, dIs/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 25 \text{ A}$			28			
Charge Time	t _a				14		ns	
Discharge Time	t _b				14			
Reverse Recovery Charge	Q _{RR}				18		nC	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

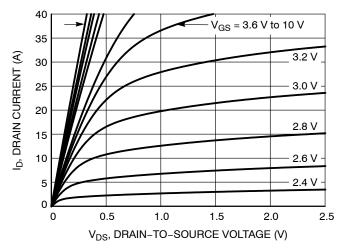


Figure 1. On-Region Characteristics

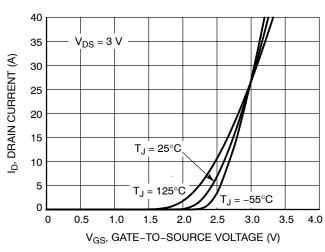


Figure 2. Transfer Characteristics

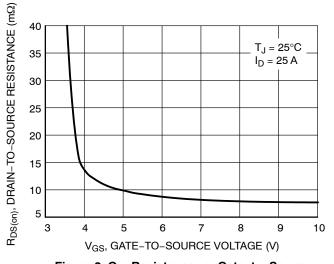


Figure 3. On-Resistance vs. Gate-to-Source Voltage

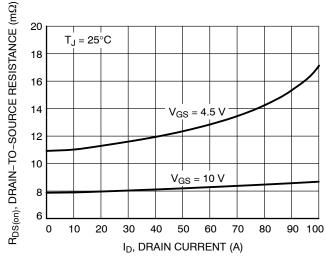


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

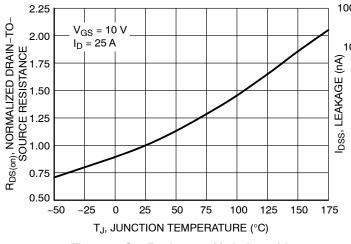


Figure 5. On–Resistance Variation with Temperature

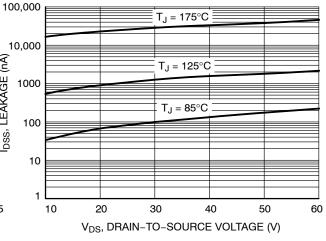
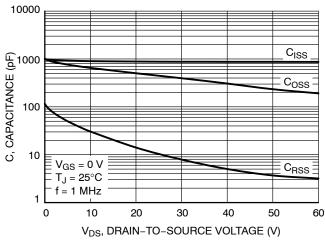


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

9 8

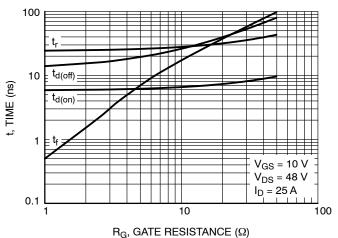


GATE-TO-SOURCE VOLTAGE (V) 7 6 5 Q_{GD} Q_{GS} 4 3 V_{DS} = 30 V 2 $T_J = 25^{\circ}C$ V_{GS}, I_D = 25 A 0 5 2 3 6 8 9 0 4 10

 Q_T

Figure 7. Capacitance Variation

Q_G, TOTAL GATE CHARGE (nC) Figure 8. Gate-to-Source vs. Total Charge



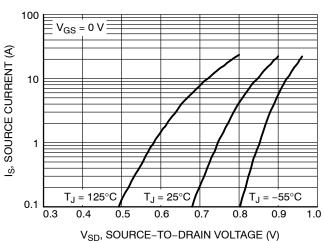
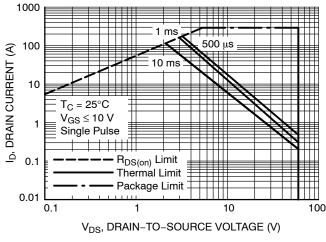


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current



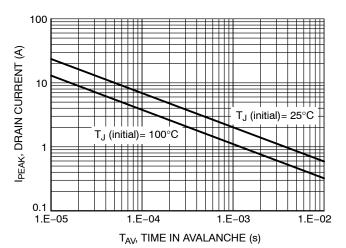


Figure 11. Maximum Rated Forward Biased Safe Operating Area

Figure 12. Maximum Drain Current vs. Time in **Avalanche**

TYPICAL CHARACTERISTICS

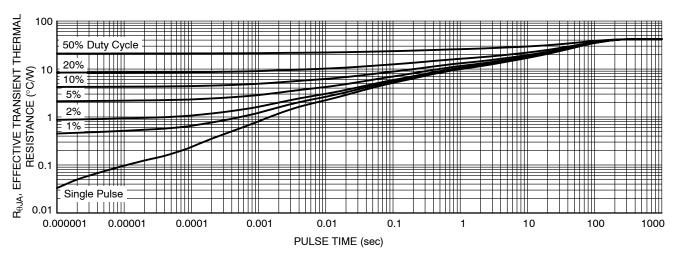
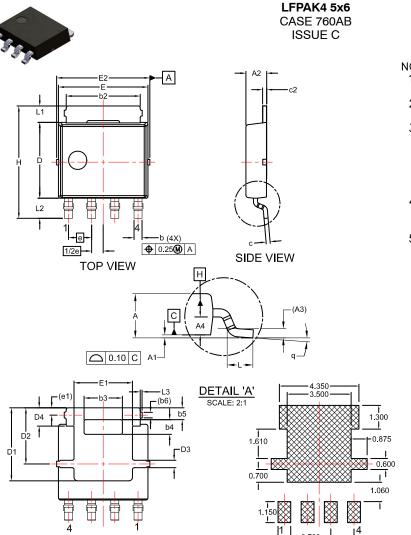


Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVMYS9D3N06CLTWG	9D3N06CL	LFPAK4 (Pb-Free)	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



DATE 19 NOV 2019

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS.
- 3. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.150mm PER SIDE.
- 4. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 5. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

UNIT IN MILLIMETER			
DIM	MIN	NOM	MAX
Α	1.10	1.20	1.30
A1	0.00	0.08	0.15
A2	1.10	1.15	1.20
A3	().25 REF	=
A4	0.45	0.50	0.55
b	0.40	0.45	0.50
b2	3.80	4.10	4.40
b3	2.00	2.10	2.20
b4	0.70	0.80	0.90
b5	0.55	0.65	0.75
b6	_	0.31 REI	
С	0.19	0.22	0.25
c2	0.19	0.22	0.25
D	4.05	4.15	4.25
D1	3.80	4.00	4.20
D2	3.00	3.10	3.20
D3	0.30	0.40	0.50
D4	0.90	1.00	1.10
Е	4.80	4.90	5.00
E1	3.10	3.20	3.30
E2	5.00	5.15	5.30
е		1.27 BS0	
1/2e		0.635 BS	
e1	0.40 REF		
Н	6.00	6.15	6.30
L	0.40	0.65	0.85
L1	0.80	0.90	1.00
L2	0.90	1.10	1.30
L3	0.00	0.10	0.20
q	0°	4°	8°

RECOMMENDED LAND PATTERN

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

GENERIC MARKING DIAGRAM*

BOTTOM VIEW



XXXXXX = Specific Device Code A = Assembly Location

WL = Wafer Lot
Y = Year

Y = Year W = Work Week

*This information is generic. Please refer to device data sheet for actual part marking. Some products may not follow the Generic Marking.

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MC78L08ACDG FDBL0150N80 FEBFL7733A_L53U021A MOC3042SM FPF2701MX FQD5N15TM FXLA104UM12X GF1B

MUR3060WTG BS170_D74Z NCP1117DTAG NCV303LSN45T1G NCV551SN32T1G NDF04N60ZH NGTB10N60FG

NL17SZ125DTT1G NLSX5014DR2G 1N5226B 1N5339B NSP8818MUTAG NTMFS6B05NT1G 1SMB5926BT3G 2SC3648T-TD-E

ESD11N5.0ST5G FAN53600AUC33X FCP20N60 FDLL400 FDPC8016S FGH20N60SFDTU FGH40N60SFDTU SURA8220T3G

FPF2124 FQD10N20CTM 2N5657G